Implementation of Digital Logic Circuits

This lecture gives an overview of how of digital logic circuits are implemented.

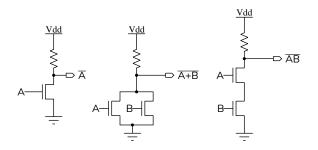
After this lecture you should be able to: state which transistors are on and off in a CMOS totem-pole output; determine the direction of current flow between driver and receiver; determine from a data sheet: if an input or output voltage would be high, low or invalid and calculate noise margin; compute the effect of frequency and voltage changes on the power consumption of CMOS logic circuits and battery life; determine the RC time constant and current consumption of an open-collector output; describe the causes and consequences of ESD; design simple circuits to convert between logic levels; distinguish between DIP, TQFP, BGA and CSP packages.

Transistor Switches

Modern digital logic circuits are implemented using (enhancement-mode) MOSFETs.

As you've learned in other courses, an n-channel MOSFET allows current flow from drain to source when the gate is more positive than the source by more than a threshold voltage. Logic circuits are designed so the transistor is either fully on ($V_{\rm GS} >> V_{\rm th}$) or fully off ($V_{\rm GS} \approx 0$).

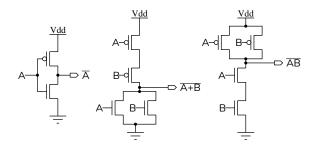
The following circuits shows how NOT, NAND and NOR gates could be implemented using nchannel MOSFETS¹:



When one (for NOT), either A or B (for OR) or both A and B for (AND) inputs are high (> V_{th}) the transistors pull the output low. The resistor pulls the output high otherwise.

These "nMOS" circuits were relatively simple to manufacture since they used only n-channel MOS-FETS. However, they draw current through the current-limiting resistance when the output is low. This resistance increases the rise time of the output which in turn limits the maximum clock rate, typically to a few MHz.

Modern digital circuits use a combination of nand p-channel MOSFETS in complementary pairs, called CMOS, to eliminate the current-limiting resistance. This reduces power consumption and increases switching speeds. Examples of CMOS NOT, NAND and NOR gate circuits are:



In each case the appropriate combination of NMOS transistors are turned on to pull the output low. Otherwise the PMOS transistor(s) pull the output high.

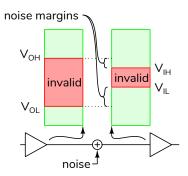
Exercise 1: In which direction does the output current flow when the output is high? When it is low? Which transistors in the NAND circuit are on (conducting) in each case?

Due to the vertical arrangement of the p- and nchannel transistors in the schematic, this is sometimes called a "totem-pole" output.

Logic levels and Noise Margins

Logic ICs are manufactured using different types of transistors – bipolar transistors (also known as Transistor-Transistor Logic or TTL) or MOSFET transistors. They are also designed for different power supply voltages (often used are 5, 3.3, 2.5, 1.8, or 1.2 V). Each of these "logic families" has different input and output levels corresponding to high and low logic levels. The diagram below shows the specifications for output and input logic levels:

¹These MOSFET symbols are often used in IC schematics.



Noise is an unpredictable voltage or current superimposed on (added to) a signal. Noise in digital circuits results from voltage drops along shared power supply and ground conductors and inductive or capacitive coupling between conductors. As shown above, noise causes the input voltage to be different than the output voltage.

The noise voltage required for an output voltage to fall into the invalid input voltage range is called the *noise margin*:

- noise margin(low) = $V_{IL(max)} V_{OL(max)}$
- noise margin(high) = $V_{OH(min)} V_{IH(min)}$

A negative noise margin means that the interface may not work properly because some output logic levels may not be recognized correctly.

Exercise 2: A logic family has $V_{OH}(min) = 5 \text{ V}$, $V_{OL}(max) = 0.5 \text{ V}$, $V_{IH}(min) = 4 \text{ V}$ and $V_{II}(max) = 1.5 \text{ V}$. What are the noise margins?

Power Consumption

MOSFET gates are insulated from both the source and the drain and can be considered as small capacitors that do not draw current except when being charged or discharged. The average power consumption of a CMOS logic circuit can be approximated as the product of the voltage (*V*) to which the gate capacitance (*C*) is being charged and the current: $I = \Delta Q/\Delta T = CVf$. Thus $P = IV = CV^2 f$.

When comparing power consumption in CMOS digital logic circuits for two operating conditions, the ratio of the power consumption is thus:

$$\frac{P_2}{P_1} = \frac{f_2}{f_1} \cdot \left(\frac{V_2}{V_1}\right)^2$$

Exercise 3: All else being equal, by how much would we expect to decrease power consumption when reducing logic levels from 5 V to

3.3 V? What would be the effect on power consumption in reducing the clock frequency from 50 MHz to 1 MHz?

Power consumption is particularly important for devices that operate on battery power. The capacity (C) of a battery, the energy stored in it, is typically specified in units of current×time (e.g. milliamphours, mA-h), or power×time (e.g. mW-h), instead of Joules.

Exercise 4: If a circuit draws 100 mA for $100 \mu \text{s}$ per second and draws $100 \mu \text{A}$ the rest of the time, how long will a 1000 mAh battery last?

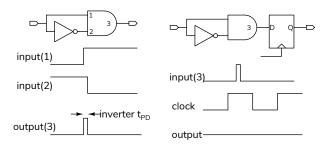
Exercise 5: 18650 cells weigh about 50 g, output 3.7 V and have a capacity of 3500 mA-h. How many cells are needed to build an 85 kWh EV battery? How much does it weigh?

Multi-Voltage ICs

Some IC's have different supply voltages for their internal logic circuits and for I/O. By using a lower voltage (e.g. 1.2 V) for internal ("core") logic and a higher voltage for I/O (e.g. 3.3 V) power consumption can be reduced while maintaining noise immunity.

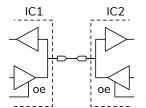
Glitches

Glitches are short pulses that result from different propagation delays in a circuit. For example:



Glitches on IC outputs increase power consumption and noise. Increased power consumption results from charging and discharging interconnect capacitances for each glitch. The short glitch duration allows it to be readily coupled to other signals and to be radiated. This increases noise.

For these reasons it's important to avoid glitches on IC outputs. Putting a flip-flop at the output eliminates the glitch because the flip-flop is only updated at clock edges. It's good practice to "register" outputs as shown above. A bidirectional pin is implemented by connecting both an input and an output to the same pin:



To connect multiple outputs in parallel we must ensure that only one output is enabled at a time. Otherwise two devices could try to drive the same net to different levels. This is called contention and results in excessive current and, potentially, damage.

There are two approaches to avoiding contention between outputs.

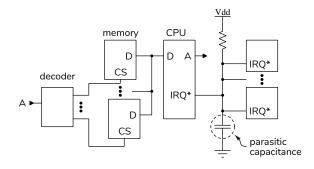
The first is a "tri-state" output together with an output-enable control. When the output is not enabled both totem-pole output transistors are turned off so that the output neither sources nor sinks current.

A circuit using tri-state outputs must be designed so that only one of the device's enable signals is asserted at a time. A common application for tri-state outputs is a memory data bus that is connected in parallel to multiple memory devices. The bank-select (chip-select) signal is used to ensure that only one memory device's output is enabled at any time.

The second approach is an "open-drain" output (called open-collector for bipolar output transistors). In this case the output can only sink, not source current and an external pull-up resistor is used to pull the bus high when no device is pulling it low.

A common application for this "wired-or" configuration is a microprocessor active-low interrupt input that can be connected in parallel to multiple devices' interrupt request outputs. One disadvantage of an open-collector/open-drain output approach is that the circuit draws current whenever the signal is being pulled low. Another is that the rise time, determined by the RC time constant of the net, can be significant.

The following diagram shows examples of both types of bidirectional buses:



Exercise 6: What are the active-state current and the RC time constant for a wired-or interrupt-request line using a $10k\Omega$ resistor pulling up a circuit with 50 pF capacitance to 3.3 V?

ESD Damage

If there are two objects with a charge difference (Q) and capacitance (C) between them², the result is voltage difference equal to V = Q/C. When these two objects are connected – equivalent to connecting the two leads of a capacitor – a current will flow from one to the other to equalize the charge. This is called electrostatic discharge (ESD).

If the voltage is applied to an IC pin, it may be enough to damage the thin dielectric (insulating layer) in a semiconductor device. This will damage the device.

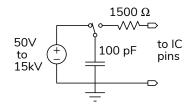
The effect of the damage may be a parameter such as increased leakage current or reduced input voltage tolerance that is not detected during manufacturing and testing but could cause failures when the device is stressed when in service.

Although most ICs have protection diodes to discharge excessive voltages and reduce the risk of ESD damage, this protection can be overwhelmed. Manufacturers and repair facilities thus follow procedures to ensure that semiconductors are not subject to ESD. Failure to follow these procedures could lose a company its quality certification and make it liable for inservice failures.

A "Human Body Model" is used for testing devices' protection against ESD. This is a small capacitor charged to a test voltage and then discharged through a resistor to the pins of the device being tested. A sequence of pulses of different polarities is

 $^{^{2}}$ Fun fact: depending on where you're standing and your footwear, your body forms a capacitor of about 50–250 pF with "ground".

applied and then the functionality of the device is retested. current drain and the RC time constant for the rise time of the signal.



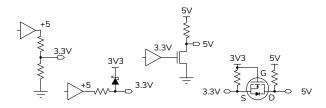
Strict ESD procedures might be ignored when the consequences of device failure are small (e.g. teaching and prototyping labs).

Logic Level Conversion

A common problem is interfacing logic families that use different, and incompatible, logic levels.

No additional hardware may be required. For example, some CMOS IC's operating from a 3.3 V supply are "5V tolerant" and the high output level is high enough to drive 5 V inputs.

Alternatively, the circuits below show some simple solutions that are appropriate when fast switching speeds are not required:



If the high output voltage is too high, a resistive voltage divider or a current-limiting resistor and a (Schottky) diode clamp³ to the lower supply voltage can be used. If the high output voltage is too low⁴, an open-collector output or n-channel MOSFET and pull-up resistor can be used.

If a bidirectional level conversion is required, an NMOS transistor can be used that allows either side to pull the other side low (when the 3.3V side is low the MOSFET is on and pulls the 5V side low; when the 5V side is low the body diode between the source terminal and the drain pulls the 3.3V side low).

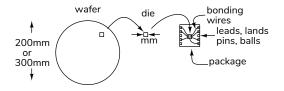
The disadvantages of these circuits, shared with open-collector outputs, is the steady-state low-level

IC Packages

The die that are cut from silicon wafers after manufacturing must be packaged to that they can be connected to circuits. Many packaging options have been developed.

In the simplest approach, "chip on board," the die is glued to a printed circuit board (PCB) and thin wires are bonded (welded) from conductive pads on the die to the PCB. A protective blob of epoxy is then applied over the die.

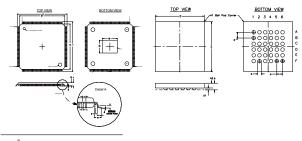
A more flexible approach is to attach the die to a plastic or ceramic package and use wire bonds to attach the IC's pads to pins, leads, lands or balls:



Exercise 7: The Apple M3 CPU has an area of approximately 146 mm². How many die fit on one 300 mm wafer? If each wafer costs \$20,000 to manufacture, what is the cost per die?

There are a wide variety of packages available. You've used dual-in-line (DIP) packages which are suitable for "through-hole" mounting. The IC on your CPLD or FPGA board uses a TQFP (thin quad flat package) which is suitable for "surface-mount" circuit boards. Higher densities can be achieved with BGA (ball-grid array) packages which have an rectangular array of connecting solder balls on the bottom.

The diagrams below show examples of the outlines for TQFP and BGA packages⁵. The e dimensions (pitch) are 0.5 mm and 0.4 mm and the D and E dimensions (width or length) are 22 mm and 3.5 mm for the 144-pin TQFP and the 64-pin BGA packages respectively.



⁵From Intel datasheets.

³Sometimes a suitable clamp diode is included in the input of the lower-voltage device.

⁴Note that $V_{OH}(\min)$ for CMOS logic outputs with 3.3 V supplies is typically high enough to drive 5 V inputs directly.

Exercise 8: How many square mm of PCB area does each package require? Which packages have their pins accessible when the package is placed on the PCB?

BGA and TQFP packages have approximately the same pitch (distance between pins) but the number of BGA pins is proportional to the product of the two dimensions while the number of TQFP pins is proportional to the sum of the two dimensions. BGA's require more complex assembly but they are useful when the smallest possible package is required. They are the only choice for IC's with a large number (hundreds) of pins.

Modern ICs use "chip-scale" packages (CSP) that are approximately the same size as the die (millimetres). The die is flipped over and pads along the top or edge of the die are soldered to the PCB.